

**Search Notes**

Application/Control No.

10/642,291

Examiner

John S. Chu

Applicant(s)/Patent under  
Reexamination

YASUNAMI ET AL.

Art Unit

1795

**SEARCHED**

Class	Subclass	Date	Examiner
430	270.1	1/2008	JSC
430	905	L	L
430	910	L	L

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH IN FILE	1/2008	JSC